Determining the wavelength of a coherent light source via Michelson interferometry

Laura Cui

October 2021

MIT Department of Physics

Introduction

- Michelson interferometry commonly used in optical experiments
- Most well-known in 1887 Michelson-Morley experiment
- Applications in probing phenomena in fundamental physics e.g. gravitational waves
- Ranges in scale from tabletop setup to several kilometers

Motivation

- Measure wavelength of coherent light source using Michelson interferometry
- Use properties of interference to align optical setups

Interference

- Can be understood using classical wave mechanics
- Different waves traveling in a medium superimpose onto each other
- Special case in which two waves have the same frequency

Interference (cont'd.)

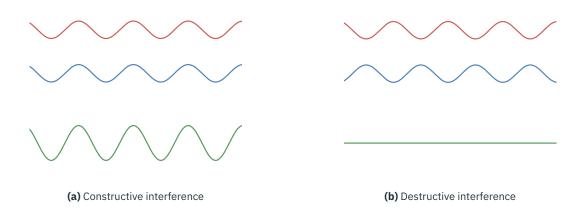


Figure 1: Interference patterns for two waves of the same frequency

Experimental setup

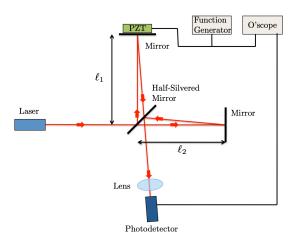


Figure 2: Diagram of Junior Lab Michelson interferometer setup ¹

¹http://web.mit.edu/8.13/www/JLExperiments/JLExp009.pdf

Michelson interferometer

- Features beamsplitter which reflects half of incident light beam into top arm and allows other half of beam to pass through
- ullet Achieved using thin coating which reflects half of incident light at 45 $^\circ$
- Observe interference where light rays recombine at beamsplitter

Piezoelectric transducer (PZT)

- Piezoelectric materials undergo mechanical strain when subjected to an applied voltage difference, and vice versa
- PZT combines piezoelectric sensor with actuator
- Changes length of arm when different voltages are applied
- Calibration factor of our device was determined as 46.7 \pm 4.2 nm/V

Results and analysis

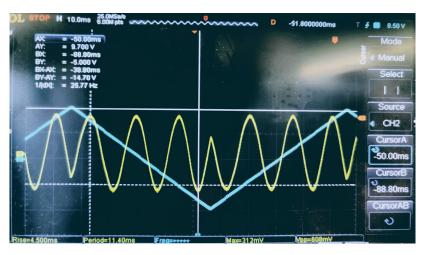


Figure 3: Photodetector and function generator output signal shown on oscilloscope

Results and analysis (cont'd.)

- Generated signal with $V_{pp}=$ 20 V, corresponding to displacement of 934 \pm 84 nm
- Measured 15.52 ms between peaks in photodetector output, corresponding to displacement of $\Delta_l=290\pm26$ nm
- Relative uncertainty in measurement of period is assumed to be less than 1%
- Wavelength measured as $2\Delta_l = 580 \pm 52$ nm
- Achieved visibility of 0.942 with maximum peak voltage of 2.680 V, minima at 80 mV

Conclusions

- Wavelength of an unknown coherent light source can be accurately determined using only interference patterns
- Use of Michelson interferometry for calibration limited by precision of optical parts
- Visibility affected by variety of factors including beamsplitter precision and photodetector dark current

Acknowledgements

- · Richard Luhtaru
- Andy Reyna
- Prof. Gunther Roland
- Junior Lab course staff